3	earch	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	-
10/538,615	BUTZMANN, STEFAN	
Examiner	Art Unit	_
Jay M. Patidar	2862	

SEARCHED			
Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
324	207.2\$	6/22/2006	JP	
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SEARCH NOT (INCLUDING SEARCH S)
	DATE	EXMR
327/207.2,207.12,207.21,207.24;338/ 32R,338/32H	6/22/2006	JP
EAST searched		
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